

**Search Notes**

Application/Control No.

10/780,755

Examiner

Rita Leykin

Applicant(s)/Patent under  
Reexamination

CHEN, DUKE

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
318	480	4/1/2005	R.L.
	16		
49	28		
342	107		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, DERWENT, EPO, JPO USPGPUB	4/1/2005	R.L.